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Sheet 1 of

Application Number	10/040,953
Filing Date	1/5/02
First Named Inventor	Steven Teig
Group Art Unit	2881 28 25
Examiner Name	ANDREA LIU
Attorney Docket Number	SPLX.P0024

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Sheet 2 of

	Application Number	10/040,953
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	First Named Inventor	Steven Teig
	Group Art Unit	268 7 28 25
	Examiner Name	ANDREA LIU
_	Attorney Docket Number	SPLX.P0024

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Sheet	3	of	3	Attorney Docket Number	SPLX.P0024	

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APR 2 8 2003 PADEM! **Application Number** 10/040,953 Substitute for form 1449A/PTO Filing Date 1/5/02 **INFORMATION DISCLOSURE** First Named Inventor Steven Teig STATEMENT BY APPLICANT Group Art Unit (use as many sheets as necessary) **Examiner Name** Sheet 4 4 Attorney Docket Number

		NON PATENT LITERATURE DOCUMENTO	
Examiner*	Cite	NON PATENT LITERATURE DOCUMENTS	
Initials	No.1	serial, symposium, catalog, etc.), date, page(s), volume-issue (when appropriate), the of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue (united the page (s), volume-issue)	T <sup>6</sup>
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (use as many sheets as necessary)				First Named Inventor	Steven Teig
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				Examiner Name	ANDREA LIMTechnology Center 260
Sheet	5	of	5	Attorney Docket Number	SPLX.P0024

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